


<b>Search Notes</b>  	<b>Application/Control No.</b>  10540065	<b>Applicant(s)/Patent Under Reexamination</b>  WANEZAKI ET AL.
	<b>Examiner</b>  Anthony Weier	<b>Art Unit</b>  1794

SEARCHED			
Class	Subclass	Date	Examiner
426	634, 426, 428, 429, 430	9/27/08	aw
updated	previous search	4/26/09	aw

SEARCH NOTES			
Search Notes		Date	Examiner
INVENTOR SEARCH		9/28/08	aw
PGPub Text Search		4/26/09	aw

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
426	634, 426, 428, 429, 430	4/26/09	aw

--	--